Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/618,157	VIGH ET AL.	
Examiner	Art Unit	
Matthew L. Fedowitz	1623	

	SEARCHED			
Class	Subclass	Date	Examiner	
514	476	9/26/2005	MLF	
514	507	9/26/2005	MLF	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
STN		9/26/2005	MLF
EAST		9/26/2005	MLF